Features

- 32-Mbit Flash and 4-Mbit/8-Mbit SRAM
- Single 66-ball (8 mm x 10 mm x 1.2 mm) CBGA Package
- 2.7V to 3.3V Operating Voltage

Flash

- 2.7V to 3.3V Read/Write
- Access Time 70 ns
- Sector Erase Architecture
 - Sixty-three 32K WordSectors with Individual Write Lockout
 - Eight 4K Word Sectors with Individual Write Lockout
- Fast Word Program Time 15 μs
- Sector Erase Time 300 ms
- Suspend/Resume Feature for Erase and Program
 - Supports Reading and Programming from Any Sector by Suspending Erase of a Different Sector
 - Supports Reading Any Word by Suspending Programming of Any Other Word
- Low-power Operation
 - 12 mA Active
 - 13 µA Standby
- Data Polling, Toggle Bit, Ready/Busy for End of Program Detection
- VPP Pin for Write Protection and Accelerated Program/Erase Operations
- RESET Input for Device Initialization
- Sector Lockdown Support
- Top or Bottom Boot Block Configuration Available
- 128-bit Protection Register
- Minimum 100,000 Erase Cycles

SRAM

- 4-megabit (256K x 16)/8-megabit (512K x 16)
- 2.7V to 3.3V V_{CC}
- 70 ns Access Time
- Fully Static Operation and Tri-state Output
- 1.2V (Min) Data Retention
- Industrial Temperature Range

Device Number	Flash Boot Location	Flash Plane Architecture	SRAM Configuration
AT52BR3224A	Bottom	32M	256K x 16
AT52BR3224AT	Тор	32M	256K x 16
AT52BR3228A	Bottom	32M	512K x 16
AT52BR3228AT	Тор	32M	512K x 16



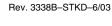
32-megabit
Flash
+ 4-megabit/
8-megabit

Stack Memory

SRAM

AT52BR3224AT AT52BR3224AT AT52BR3228A AT52BR3228AT

Preliminary







Pin Configuration

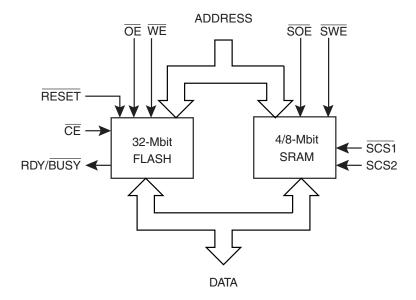
Pin Name	Function
A0 - A17	Flash/SRAM Common Address Input for 4M SRAM
A0 - A18	Flash/SRAM Common Address Input for 8M SRAM
A19 - A20	Flash Address Input
CE	Flash Chip Enable
ŌĒ	Flash Output Enable
WE	Flash Write Enablee
RESET	Flash Reset
RDY/BUSY	Flash READY/BUSY Output
VPP	Flash Power Supply for Accelerated Program/Erase Operations
VCC	Flash Power
GND	Flash Ground
I/O0 - I/O15	Data Inputs/Outputs
NC	No Connect
SLB	SRAM Lower Byte
SUB	SRAM Upper Byte
SVCC	SRAM Power
SGND	SRAM Ground
SCS1	SRAM Chip Select 1
SCS2	SRAM Chip Select 2
SWE	SRAM Write Enable
SOE	SRAM Output Enable

AT52BR3224A(T)/ AT52BR3228A(T) (Top View)

_	1	2	3	4	5	6	7	8	9	10	11	12	
	•												
Α	\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	
	NC	NC	A20	A11	A15	A14	A13	A12	GND	NC	NC	NC	
В			\bigcirc	\bigcirc	\bigcirc	\bigcirc	\bigcirc	\subseteq	\bigcirc	\bigcirc			
			A16	A8	A10	A9	1/015	SWE	1/014	1/07			
C			$\underline{\circ}$	\circ _	_		\bigcirc	\bigcirc	\bigcirc	\bigcirc			
_				RDY/BUS	Y		1/013	1/06	VO4	VO5			
D			\circ	\subseteq			\bigcirc	\circ	\circ	\bigcirc			
_			SGND	RES	~	\sim	1/012	SCS2	SVCC	VCC			
E			\bigcirc	\bigcirc	\circ	\circ		()	\bigcirc	()			
F			NC	VPP	A19	I/O11	\sim	I/O10	1/02	I/O3			
ᄗ							\bigcirc	()	\bigcirc	\bigcirc			
G			SLB ()	SUB	SOE	\bigcirc	I/O9	I/08	I/00 ()	l/01 ○			
٦			A18	A17	A7	A6	A3	A2	A1	SCS1			
н	\bigcirc	\bigcirc		\bigcirc	$\stackrel{A_{\prime}}{\bigcirc}$			\bigcirc	\bigcirc	()	\bigcirc	\bigcirc	
-''	NC	NC	NC	A5	A4	A0	CE	GND	OE	NC	NC	NC	

2

Block Diagram



Description

The AT52BR3224A(T) combines a 32-megabit Flash (2M x 16) and a 4-megabit SRAM (organized as 256K x 16) in a stacked 66-ball CBGA package. The AT52BR3228A(T) combines a 32-megabit Flash (2M x 16) and an 8-megabit SRAM (organized as 512K x 16) in a stacked 66-ball CBGA package. The stacked modules operate at 2.7V to 3.3V in the industrial temperature range.

Absolute Maximum Ratings

Temperature under Bias	-40°C to +85°C
Storage Temperature5	55°C to +150°C
All Input Voltages except V _{PP} and RESET (including NC Pins) with Respect to Ground	0.2V to +3.3V
Voltage on V _{PP} with Respect to Ground	0.2V to + 6.25V
Voltage on RESET with Respect to Ground	-0.2V to +13.5V
All Output Voltages with Respect to Ground	0.2V to +0.2V

*NOTICE:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

DC and AC Operating Range

		AT52BR3224A(T)/3228A(T)-70
Operating Temperature (Case)	Industrial	-40° C - 85° C
V _{CC} Power Supply		2.7V to 3.3V





32-megabit Flash Memory Description

The 32-megabit Flash is a a 2.7-volt memory organized as 2,097,152 words of 16 bits each. The memory is divided into 71 sectors for erase operations. The device has $\overline{\text{CE}}$ and $\overline{\text{OE}}$ control signals to avoid any bus contention. This device can be read or reprogrammed using a single power supply, making it ideally suited for in-system programming.

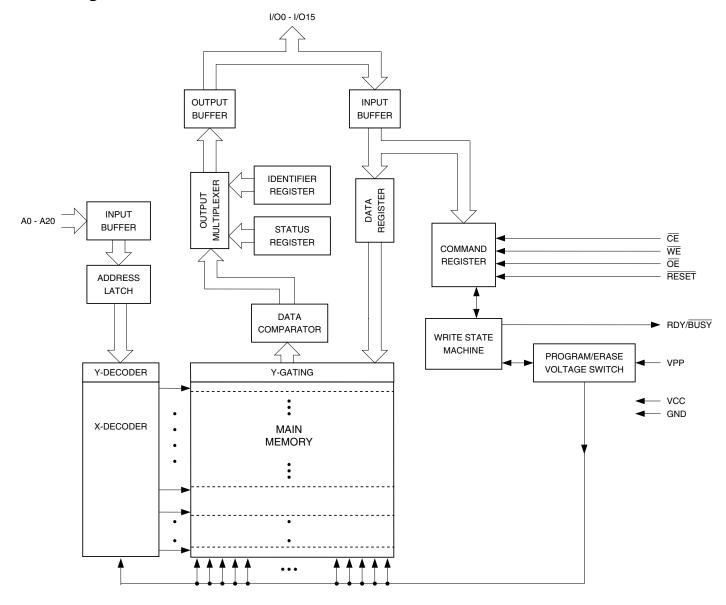
The device powers on in the read mode. Command sequences are used to place the device in other operation modes such as program and erase. The device has the capability to protect the data in any sector (see "Sector Lockdown" section).

To increase the flexibility of the device, it contains an Erase Suspend and Program Suspend feature. This feature will put the erase or program on hold for any amount of time and let the user read data from or program data to any of the remaining sectors within the memory. The end of a program or an erase cycle is detected by the READY/BUSY pin, Data Polling or by the toggle bit.

The VPP pin provides data protection. When the V_{PP} input is below 0.4V, the program and erase functions are inhibited. When V_{PP} is at 0.9V or above, normal program and erase operations can be performed.

A six-byte command (Enter Single Pulse Program Mode) sequence to remove the requirement of entering the three-byte program sequence is offered to further improve programming time. After entering the six-byte code, only single pulses on the write control lines are required for writing into the device. This mode (Single Pulse Word Program) is exited by powering down the device, or by pulsing the $\overline{\text{RESET}}$ pin low for a minimum of 500 ns and then bringing it back to V_{CC} . Erase, Erase Suspend/Resume and Program Suspend/Resume commands will not work while in this mode; if entered they will result in data being programmed into the device. It is not recommended that the six-byte code reside in the software of the final product but only exist in external programming code.

Block Diagram







Device Operation

READ: The 32-Mbit Flash memory is accessed like an EPROM. When \overline{CE} and \overline{OE} are low and \overline{WE} is high, the data stored at the memory location determined by the address pins are asserted on the outputs. The outputs are put in the high impedance state whenever \overline{CE} or \overline{OE} is high. This dual-line control gives designers flexibility in preventing bus contention.

COMMAND SEQUENCES: When the device is first powered on, it will be reset to the read or standby mode, depending upon the state of the control line inputs. In order to perform other device functions, a series of command sequences are entered into the device. The command sequences are shown in the "Command Definition in Hex" table on page 14 (I/O8 - I/O15 are don't care inputs for the command codes). The command sequences are written by applying a low pulse on the $\overline{\rm WE}$ or $\overline{\rm CE}$ input with $\overline{\rm CE}$ or $\overline{\rm WE}$ low (respectively) and $\overline{\rm OE}$ high. The address is latched on the falling edge of $\overline{\rm CE}$ or $\overline{\rm WE}$, whichever occurs last. The data is latched by the first rising edge of $\overline{\rm CE}$ or $\overline{\rm WE}$. Standard microprocessor write timings are used. The address locations used in the command sequences are not affected by entering the command sequences.

RESET: A RESET input pin is provided to ease some system applications. When RESET is at a logic high level, the device is in its standard operating mode. A low level on the RESET input halts the present device operation and puts the outputs of the device in a high impedance state. When a high level is reasserted on the RESET pin, the device returns to the read or standby mode, depending upon the state of the control inputs.

ERASURE: Before a word can be reprogrammed, it must be erased. The erased state of memory bits is a logical "1". The entire device can be erased by using the Chip Erase command or individual sectors can be erased by using the Sector Erase command.

CHIP ERASE: The entire device can be erased at one time by using the six-byte chip erase software code. After the chip erase has been initiated, the device will internally time the erase operation so that no external clocks are required. The maximum time to erase the chip is t_{EC}.

If the sector lockdown has been enabled, the chip erase will not erase the data in the sector that has been locked out; it will erase only the unprotected sectors. After the chip erase, the device will return to the read or standby mode.

SECTOR ERASE: As an alternative to a full chip erase, the device is organized into 71 sectors (SA0 - SA70) that can be individually erased. The Sector Erase command is a six-bus cycle operation. The sector address is latched on the falling \overline{WE} edge of the sixth cycle while the 30H data input command is latched on the rising edge of \overline{WE} . The sector erase starts after the rising edge of \overline{WE} of the sixth cycle. The erase operation is internally controlled; it will automatically time to completion. The maximum time to erase a sector is t_{SEC} . When the sector programming lockdown feature is not enabled, the sector will erase (from the same Sector Erase command). An attempt to erase a sector that has been protected will result in the operation terminating immediately.

WORD PROGRAMMING: Once a memory block is erased, it is programmed (to a logical "0") on a word-by-word basis. Programming is accomplished via the internal device command register and is a four-bus cycle operation. The device will automatically generate the required internal program pulses.

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Any commands written to the chip during the embedded programming cycle will be ignored. If a hardware reset happens during programming, the data at the location being programmed will be corrupted. Please note that a data "0" cannot be programmed back to a "1"; only erase operations can convert "0"s to "1"s. Programming is completed after the specified t_{BP} cycle time. The Data Polling feature or the Toggle Bit feature may be used to indicate the end of a program cycle. If the erase/program status bit is a "1", the device was not able to verify that the erase or program operation was performed successfully.

VPP PIN: The circuitry of the 32-Mbit Flash is designed so that the device cannot be programmed or erased if the V_{PP} voltage is less that 0.4V. When V_{PP} is at 0.9V or above, normal program and erase operations can be performed. The VPP pin cannot be left floating.

PROGRAM/ERASE STATUS: The device provides several bits to determine the status of a program or erase operation: I/O2, I/O3, I/O5, I/O6 and I/O7. The "Status Bit Table" on page 13 and the following four sections describe the function of these bits. To provide greater flexibility for system designers, the device contains a programmable configuration register. The configuration register allows the user to specify the status bit operation. The configuration register can be set to one of two different values, "00" or "01". If the configuration register is set to "00", the part will automatically return to the read mode after a successful program or erase operation. If the configuration register is set to a "01", a Product ID Exit command must be given after a successful program or erase operation before the part will return to the read mode. It is important to note that whether the configuration register is set to a "00" or to a "01", any unsuccessful program or erase operation requires using the Product ID Exit command to return the device to read mode. The default value (after power-up) for the configuration register is "00". Using the four-bus cycle Set Configuration Register command as shown in the "Command Definition in Hex" table on page 14, the value of the configuration register can be changed. Voltages applied to the RESET pin will not alter the value of the configuration register. The value of the configuration register will affect the operation of the I/O7 status bit as described below.

DATA POLLING: The device features Data Polling to indicate the end of a program cycle. If the status configuration register is set to a "00", during a program cycle an attempted read of the last word loaded will result in the complement of the loaded data on I/O7. Once the program cycle has been completed, true data is valid on all outputs and the next cycle may begin. During a chip or sector erase operation, an attempt to read the device will give a "0" on I/O7. Once the program or erase cycle has completed, true data will be read from the device. Data Polling may begin at any time during the program cycle. Please see "Status Bit Table" on page 13 for more details.

If the status bit configuration register is set to a "01", the I/O7 status bit will be low while the device is actively programming or erasing data. I/O7 will go high when the device has completed a program or erase operation. Once I/O7 has gone high, status information on the other pins can be checked.

The Data Polling status bit must be used in conjunction with the erase/program and V_{PP} status bit as shown in the algorithm in Figures 1 and 2 on page 11.





TOGGLE BIT: In addition to Data Polling the device provides another method for determining the end of a program or erase cycle. During a program or erase operation, successive attempts to read data from the memory will result in I/O6 toggling between one and zero. Once the program cycle has completed, I/O6 will stop toggling and valid data will be read. Examining the toggle bit may begin at any time during a program cycle. Please see "Status Bit Table" on page 13 for more details.

The toggle bit status bit should be used in conjunction with the erase/program and V_{PP} status bit as shown in the algorithm in Figures 3 and 4 on page 12.

ERASE/PROGRAM STATUS BIT: The device offers a status bit on I/O5, which indicates whether the program or erase operation has exceeded a specified internal pulse count limit. If the status bit is a "1", the device is unable to verify that an erase or a word program operation has been successfully performed. If a program (Sector Erase) command is issued to a protected sector, the protected sector will not be programmed (erased). The device will go to a status read mode and the I/O5 status bit will be set high, indicating the program (erase) operation did not complete as requested. Once the erase/program status bit has been set to a "1", the system must write the Product ID Exit command to return to the read mode. The erase/program status bit is a "0" while the erase or program operation is still in progress. Please see "Status Bit Table" on page 13 for more details.

 V_{PP} STATUS BIT: The device provides a status bit on I/O3, which provides information regarding the voltage level of the VPP pin. During a program or erase operation, if the voltage on the VPP pin is not high enough to perform the desired operation successfully, the I/O3 status bit will be a "1". Once the V_{PP} status bit has been set to a "1", the system must write the Product ID Exit command to return to the read mode. On the other hand, if the voltage level is high enough to perform a program or erase operation successfully, the V_{PP} status bit will output a "0". Please see "Status Bit Table" on page 13 for more details.

SECTOR LOCKDOWN: Each sector has a programming lockdown feature. This feature prevents programming of data in the designated sectors once the feature has been enabled. These sectors can contain secure code that is used to bring up the system. Enabling the lockdown feature will allow the boot code to stay in the device while data in the rest of the device is updated. This feature does not have to be activated; any sector's usage as a write-protected region is optional to the user.

At power-up or reset, all sectors are unlocked. To activate the lockdown for a specific sector, the six-bus cycle Sector Lockdown command must be issued. Once a sector has been locked down, the contents of the sector is read-only and cannot be erased or programmed.

SECTOR LOCKDOWN DETECTION: A software method is available to determine if programming of a sector is locked down. When the device is in the software product identification mode (see "Software Product Identification Entry/Exit" sections on page 27), a read from address location 00002H within a sector will show if programming the sector is locked down. If the data on I/O0 is low, the sector can be programmed; if the data on I/O0 is high, the program lockdown feature has been enabled and the sector cannot be programmed. The software product identification exit code should be used to return to standard operation.

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SECTOR LOCKDOWN OVERRIDE: The only way to unlock a sector that is locked down is through reset or power-up cycles. After power-up or reset, the content of a sector that is locked down can be erased and reprogrammed.

ERASE SUSPEND/ERASE RESUME: The Erase Suspend command allows the system to interrupt a sector or chip erase operation and then program or read data from a different sector within the memory. After the Erase Suspend command is given, the device requires a maximum time of 15 μs to suspend the erase operation. After the erase operation has been suspended, the system can then read data or program data to any other sector within the device. An address is not required during the Erase Suspend command. During a sector erase suspend, another sector cannot be erased. To resume the sector erase operation, the system must write the Erase Resume command. The Erase Resume command is a one-bus cycle command. The device also supports an erase suspend during a complete chip erase. While the chip erase is suspended, the user can read from any sector within the memory that is protected. The command sequence for a chip erase suspend and a sector erase suspend are the same.

PROGRAM SUSPEND/PROGRAM RESUME: The Program Suspend command allows the system to interrupt a programming operation and then read data from a different word within the memory. After the Program Suspend command is given, the device requires a maximum of 20 µs to suspend the programming operation. After the programming operation has been suspended, the system can then read data from any other word within the device that is not contained in the sector in which the programming operation was suspended. An address is not required during the program suspend operation. To resume the programming operation, the system must write the Program Resume command. The program suspend and resume are one-bus cycle commands. The command sequence for the erase suspend and program suspend are the same, and the command sequence for the erase resume and program resume are the same.

PRODUCT IDENTIFICATION: The product identification mode identifies the device and manufacturer as Atmel. It may be accessed by hardware or software operation. The hardware operation mode can be used by an external programmer to identify the correct programming algorithm for the Atmel product.

For details, see "Operating Modes" on page 20 (for hardware operation) or "Software Product Identification Entry/Exit" sections on page 27. The manufacturer and device codes are the same for both modes.

128-BIT PROTECTION REGISTER: The device contains a 128-bit register that can be used for security purposes in system design. The protection register is divided into two 64-bit blocks. The two blocks are designated as block A and block B. The data in block A is non-changeable and is programmed at the factory with a unique number. The data in block B is programmed by the user and can be locked out such that data in the block cannot be reprogrammed. To program block B in the protection register, the four-bus cycle Program Protection Register command must be used as shown in the "Command Definition in Hex" table on page 14. To lock out block B, the four-bus cycle Lock Protection Register command must be used as shown in the "Command Definition in Hex" table. Data bit D1 must be zero during the fourth bus cycle. All other data bits during the fourth bus cycle are don't cares. To determine whether block B is locked out, the Product ID Entry command is given followed by a read operation from address 80H. If data bit D1 is zero, block B is locked. If data bit D1 is one, block B can be reprogrammed. Please see the "Protection Register Addressing Table" on page 15 for the address locations in the protection register. To read the protection register, the Product ID Entry command is given followed by a normal read operation from an address within the protection register. After determining whether block B is protected or not, or reading the protection register, the Product ID Exit command must be given prior to performing any other operation.





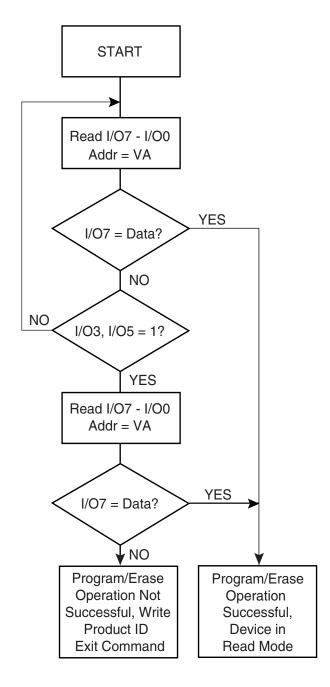
RDY/BUSY: For the 32-Mbit Flash memory, an open-drain READY/BUSY output pin provides another method of detecting the end of a program or erase operation. RDY/BUSY is actively pulled low during the internal program and erase cycles and is released at the completion of the cycle. The open-drain connection allows for OR-tying of several devices to the same RDY/BUSY line. Please see "Status Bit Table" on page 13 for more details.

HARDWARE DATA PROTECTION: The Hardware Data Protection feature protects against inadvertent programs to the device in the following ways: (a) V_{CC} sense: if V_{CC} is below 1.8V (typical), the program function is inhibited. (b) V_{CC} power-on delay: once V_{CC} has reached the V_{CC} sense level, the device will automatically time out 10 ms (typical) before programming. (c) Program inhibit: holding any one of \overline{OE} low, \overline{CE} high or \overline{WE} high inhibits program cycles. (d) Program inhibit: V_{PP} is less than V_{ILPP} . (e) V_{PP} power-on delay: once V_{PP} has reached 1.65V, program and erase operations are inhibited for 100 ns.

INPUT LEVELS: While operating with a 2.7V to 3.6V power supply, the address inputs and control inputs (\overline{OE} , \overline{CE} and \overline{WE}) may be driven from 0 to 5.5V without adversely affecting the operation of the device. The I/O lines can only be driven from 0 to V_{CC} + 0.6V.

OUTPUT LEVELS: For the device, output high levels (V_{OH}) are equal to V_{CCQ} - 0.2V (not V_{CC}). For 2.7V - 3.6V output levels, V_{CCQ} must be tied to V_{CC} . For 1.8V - 2.2V output levels, V_{CCQ} must be regulated to 2.0V \pm 10%, while V_{CC} must be regulated to 2.7V - 3.0V (for minimum power).

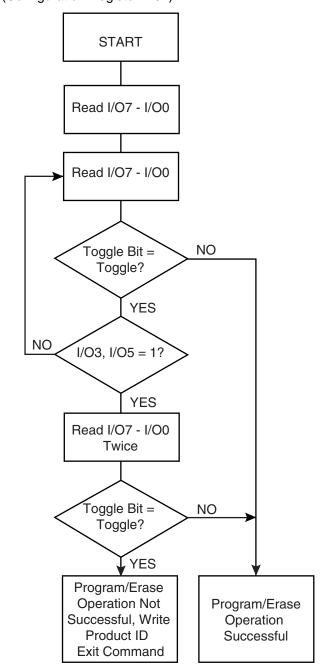
Figure 1. Data Polling Algorithm (Configuration Register = 00)



Notes:

- VA = Valid address for programming. During a sector erase operation, a valid address is any sector address within the sector being erased. During chip erase, a valid address is any non-protected sector address.
- 2. I/O7 should be rechecked even if I/O5 = "1" because I/O7 may change simultaneously with I/O5.

Figure 2. Data Polling Algorithm (Configuration Register = 01)



Note:

VA = Valid address for programming. During a sector erase operation, a valid address is any sector address within the sector being erased. During chip erase, a valid address is any non-protected sector address.





Figure 3. Toggle Bit Algorithm (Configuration Register = 00)

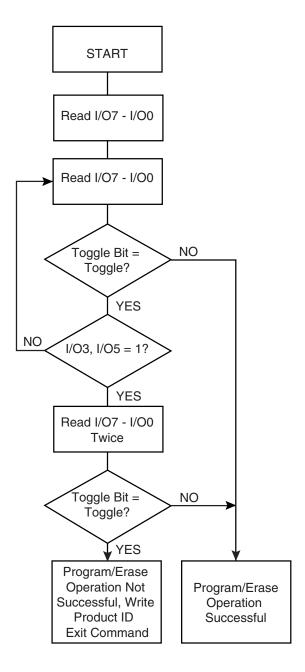
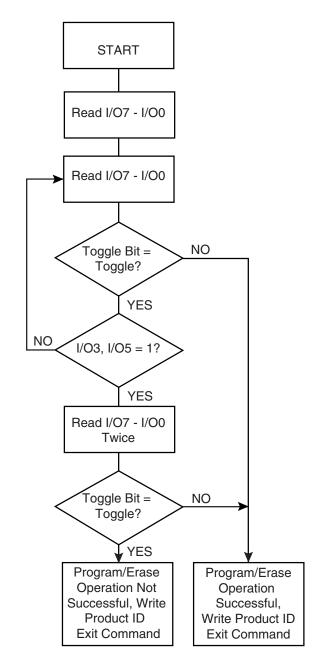


Figure 4. Toggle Bit Algorithm (Configuration Register = 01)



Note: 1. The system should recheck the toggle bit even if I/O5 = "1" because the toggle bit may stop toggling as I/O5 changes to "1".

Note: 1. The system should recheck the toggle bit even if I/O5 = "1" because the toggle bit may stop toggling as I/O5 changes to "1".

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Status Bit Table

	Status Bit						
	1/07	I/O7	I/O6	I/O5 ⁽¹⁾	I/O3 ⁽²⁾	1/02	RDY/BUSY
Configuration Register	00	01	00/01	00/01	00/01	00/01	00/01
Programming	Ī/O7	0	TOGGLE	0	0	1	0
Erasing	0	0	TOGGLE	0	0	TOGGLE	0
Erase Suspended & Read Erasing Sector	1	1	1	0	0	TOGGLE	1
Erase Suspended & Read Non-erasing Sector	DATA	DATA	DATA	DATA	DATA	DATA	1
Erase Suspended & Program Non-erasing Sector	Ī/O7	0	TOGGLE	0	0	TOGGLE	0

Notes: 1. I/O5 switches to a "1" when a program or an erase operation has exceeded the maximum time limits or when a program or sector erase operation is performed on a protected sector.

2. I/O3 switches to a "1" when the V_{PP} level is not high enough to successfully perform program and erase operations.





Command Definition in Hex⁽¹⁾

Command	Bus		1st Bus Cycle		2nd Bus Cycle		3rd Bus Cycle		4th Bus Cycle		Bus cle	6th Bus Cycle	
Sequence	Cycles	Addr	Data	Addr	Data	Addr	Data	Addr	Data	Addr	Data	Addr	Data
Read	1	Addr	D _{OUT}										
Chip Erase	6	555	AA	AAA ⁽²⁾	55	555	80	555	AA	AAA	55	555	10
Sector Erase	6	555	AA	AAA	55	555	80	555	AA	AAA	55	SA ⁽³⁾⁽⁴⁾	30
Word Program	4	555	AA	AAA	55	555	A0	Addr	D _{IN}				
Enter Single Pulse Program Mode	6	555	AA	AAA	55	555	80	555	AA	AAA	55	555	A0
Single Pulse Word Program	1	Addr	D _{IN}										
Sector Lockdown	6	555	AA	AAA ⁽²⁾	55	555	80	555	AA	AAA	55	SA ⁽³⁾⁽⁴⁾	60
Erase/Program Suspend	1	xxx	В0										
Erase/Program Resume	1	xxx	30										
Product ID Entry	3	555	AA	AAA	55	555	90						
Product ID Exit ⁽⁵⁾	3	555	AA	AAA	55	555	F0 ⁽⁸⁾						
Product ID Exit ⁽⁵⁾	1	XXX	F0 ⁽⁸⁾										
Program Protection Register	4	555	AA	AAA	55	555	C0	Addr	D _{IN}				
Lock Protection Register - Block B	4	555	AA	AAA	55	555	C0	080	X0				
Status of Block B Protection	4	555	AA	AAA	55	555	90	80	D _{OUT} ⁽⁶⁾				
Set Configuration Register	4	555	AA	AAA	55	555	D0	XXX	00/01 ⁽⁷⁾				

Notes:

- The DATA FORMAT shown for each bus cycle is as follows; I/O7 I/O0 (Hex). In word operation I/O15 I/O8
 are don't care. The ADDRESS FORMAT shown for each bus cycle is as follows: A11 A0 (Hex). Address A20 through A11
 are don't care in the word mode.
- 2. Since A11 is a Don't Care, AAA can be replaced with 2AA.
- 3. SA = sector address. Any word address within a sector can be used to designate the sector address (see pages 18-17 for details).
- 4. Once a sector is in the lockdown mode, data in the protected sector cannot be changed unless the chip is reset or power cycled.
- 5. Either one of the Product ID Exit commands can be used.
- 6. If data bit D1 is "0", block B is locked. If data bit D1 is "1", block B can be reprogrammed.
- 7. The default state (after power-up) of the configuration register is "00".
- 8. Bytes of data other than F0 may be used to exit the Product ID mode. However, it is recommended that F0 be used.

Absolute Maximum Ratings*

Temperature under Bias55°C to +125°C
Storage Temperature65°C to +150°C
All Input Voltages (including NC Pins) with Respect to Ground0.6V to +6.25V
All Output Voltages with Respect to Ground0.6V to V _{CC} + 0.6V
Voltage on V _{PP} with Respect to Ground0.6V to +13.0V

*NOTICE:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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Protection Register Addressing Table

Word	Use	Block	A 7	A6	A 5	A 4	А3	A2	A 1	Α0
0	Factory	Α	1	0	0	0	0	0	0	1
1	Factory	Α	1	0	0	0	0	0	1	0
2	Factory	Α	1	0	0	0	0	0	1	1
3	Factory	Α	1	0	0	0	0	1	0	0
4	User	В	1	0	0	0	0	1	0	1
5	User	В	1	0	0	0	0	1	1	0
6	User	В	1	0	0	0	0	1	1	1
7	User	В	1	0	0	0	1	0	0	0

Note: All address lines not specified in the above table must be "0" when accessing the protection register, i.e., A20 - A8 = 0.





Bottom Boot - Sector Address Table

	x16
Sector	Address Range (A20 - A0)
SA0	00000 - 00FFF
SA1	01000 - 01FFF
SA2	02000 - 02FFF
SA3	03000 - 03FFF
SA4	04000 - 04FFF
SA5	05000 - 05FFF
SA6	06000 - 06FFF
SA7	07000 - 07FFF
SA8	08000 - 0FFFF
SA9	10000 - 17FFF
SA10	18000 - 1FFFF
SA11	20000 - 27FFF
SA12	28000 - 2FFFF
SA13	30000 - 37FFF
SA14	38000 - 3FFFF
SA15	40000 - 47FFF
SA16	48000 - 4FFFF
SA17	50000 - 57FFF
SA18	58000 - 5FFFF
SA19	60000 - 67FFF
SA20	68000 - 6FFFF
SA21	70000 - 77FFF
SA22	78000 - 7FFFF
SA23	80000 - 87FFF
SA24	88000 - 8FFFF
SA25	90000 - 97FFF
SA26	98000 - 9FFFF
SA27	A0000 - A7FFF
SA28	A8000 - AFFFF
SA29	B0000 - B7FFF
SA30	B8000 - BFFFF
SA31	C0000 - C7FFF
SA32	C8000 - CFFFF
SA33	D0000 - D7FFF
SA34	D8000 - DFFFF
SA35	E0000 - E7FFF
SA36	E8000 - EFFFF

Bottom Boot – Sector Address Table (Continued)

Sector Address Range (A20 - A0) SA37 F0000 - FFFFF SA38 F8000 - FFFFF SA39 100000 - 107FFF SA40 188000 - 10FFFF SA41 110000 - 117FFF SA42 118000 - 117FFF SA43 120000 - 127FFF SA44 128000 - 127FFF SA45 130000 - 137FFF SA46 138000 - 13FFFF SA47 140000 - 147FFF SA48 148000 - 14FFFF SA49 150000 - 157FFF SA50 158000 - 15FFFF SA51 160000 - 16FFFF SA52 168000 - 16FFFF SA53 170000 - 17FFFF SA54 178000 - 17FFFF SA55 180000 - 18FFFF SA56 180000 - 18FFFF SA57 190000 - 18FFFF SA58 190000 - 18FFFF SA59 190000 - 18FFFF SA60 188000 - 18FFFF SA61 180000 - 18FFFF SA62 180000 - 18FFFF SA63		x16
SA38 F8000 - FFFFF SA39 100000 - 107FFF SA40 108000 - 107FFF SA41 110000 - 117FFF SA42 118000 - 117FFF SA43 120000 - 127FFF SA44 128000 - 127FFF SA45 130000 - 137FFF SA46 139000 - 137FFF SA47 140000 - 147FFF SA48 148000 - 147FFF SA49 150000 - 157FFF SA51 160000 - 167FFF SA52 168000 - 16FFFF SA53 170000 - 177FFF SA54 178000 - 177FFF SA55 180000 - 187FFF SA56 189000 - 197FFF SA57 190000 - 197FFF SA58 198000 - 187FFF SA59 1A0000 - 1A7FFF SA60 1A8000 - 187FFF SA60 1A8000 - 187FFF SA60 1A8000 - 187FFF SA60 1A8000 - 187FFF SA61 1B0000 - 187FFF SA62 1B0000 - 187FFF SA63 1C000	Sector	Address Range (A20 - A0)
SA39 100000 - 107FFF SA40 108000 - 10FFFF SA41 110000 - 117FFF SA42 118000 - 127FFF SA43 120000 - 127FFF SA44 128000 - 127FFF SA45 130000 - 137FFF SA46 138000 - 13FFFF SA47 140000 - 147FFF SA48 148000 - 14FFFF SA49 150000 - 157FFF SA50 158000 - 15FFFF SA51 160000 - 167FFF SA52 168000 - 16FFFF SA53 170000 - 177FFF SA54 178000 - 17FFFF SA55 180000 - 187FFF SA56 188000 - 18FFFF SA57 190000 - 197FFF SA68 198000 - 18FFFF SA69 1A0000 - 1A7FFF SA60 188000 - 18FFFF SA61 180000 - 18FFFF SA62 188000 - 18FFFF SA63 160000 - 17FFFF SA64 180000 - 18FFFF SA65 180000 - 18FFFF SA66 180	SA37	F0000 - F7FFF
SA40 108000 - 10FFFF SA41 110000 - 117FFF SA42 118000 - 12FFFF SA43 120000 - 12FFFF SA44 128000 - 12FFFF SA45 130000 - 137FFF SA46 138000 - 13FFFF SA47 140000 - 14FFFF SA48 148000 - 14FFFF SA49 150000 - 15FFFF SA51 160000 - 16FFFF SA52 168000 - 16FFFF SA53 170000 - 17FFFF SA54 178000 - 17FFFF SA55 180000 - 18FFFF SA56 180000 - 18FFFF SA57 190000 - 19FFFF SA58 198000 - 19FFFF SA59 1A0000 - 1A7FFF SA60 188000 - 18FFFF SA61 180000 - 1BFFFF SA62 188000 - 1BFFFF SA63 1C0000 - 1C7FFF SA64 1B0000 - 1BFFFF SA65 1B0000 - 1BFFFF SA66 1B0000 - 1BFFFF SA67 1B0000 - 1DFFFF SA68 1D0	SA38	F8000 - FFFFF
SA41 110000 - 117FFF SA42 118000 - 11FFFF SA43 120000 - 127FFF SA44 128000 - 12FFFF SA45 130000 - 13FFFF SA46 138000 - 13FFFF SA47 140000 - 14FFFF SA48 148000 - 14FFFF SA49 150000 - 15FFFF SA50 158000 - 15FFFF SA51 160000 - 16FFFF SA52 168000 - 16FFFF SA53 170000 - 17FFFF SA54 178000 - 17FFFF SA55 180000 - 18FFFF SA56 188000 - 18FFFF SA57 190000 - 19FFFF SA59 1A0000 - 1AFFFF SA60 1A8000 - 18FFFF SA61 1B0000 - 18FFFF SA62 1B0000 - 18FFFF SA63 1C0000 - 10FFFF SA64 1C0000 - 10FFFF SA63 1C0000 - 10FFFF SA64 1C0000 - 10FFFF SA65 1D0000 - 10FFFF SA66 1D0000 - 10FFFF SA66 1D0	SA39	100000 - 107FFF
SA42 118000 - 11FFFF SA43 120000 - 127FFF SA44 128000 - 12FFFF SA45 130000 - 13FFFF SA46 138000 - 13FFFF SA47 140000 - 147FFF SA48 148000 - 14FFFF SA49 150000 - 157FFF SA50 158000 - 16FFFF SA51 160000 - 16FFFF SA52 168000 - 16FFFF SA53 170000 - 177FFF SA54 178000 - 17FFFF SA55 180000 - 18FFFF SA56 188000 - 18FFFF SA67 190000 - 197FFF SA88 198000 - 19FFFF SA60 1A8000 - 1AFFFF SA61 180000 - 18FFFF SA62 188000 - 19FFFF SA63 198000 - 19FFFF SA64 168000 - 10FFFF SA65 188000 - 10FFFF SA60 188000 - 10FFFF SA61 188000 - 10FFFF SA62 188000 - 10FFFF SA63 100000 - 10FFFF SA64 100	SA40	108000 - 10FFFF
SA43 120000 - 127FFF SA44 128000 - 12FFFF SA45 130000 - 137FFF SA46 138000 - 13FFFF SA47 140000 - 14FFFF SA48 148000 - 14FFFF SA49 150000 - 157FFF SA50 158000 - 15FFFF SA51 160000 - 167FFF SA52 168000 - 16FFFF SA53 170000 - 17FFFF SA54 178000 - 18FFFF SA55 180000 - 18FFFF SA56 188000 - 18FFFF SA57 190000 - 19FFFF SA68 198000 - 19FFFF SA69 1A0000 - 1AFFFF SA60 18800 - 18FFFF SA61 188000 - 18FFFF SA62 188000 - 19FFFF SA63 100000 - 107FFF SA64 180000 - 18FFFF SA65 188000 - 18FFFF SA66 188000 - 18FFFF SA67 188000 - 10FFFF SA68 100000 - 107FFF SA66 100000 - 107FFF SA66 1000	SA41	110000 - 117FFF
SA44 128000 - 12FFFF SA45 130000 - 137FFF SA46 138000 - 13FFFF SA47 140000 - 147FFF SA48 148000 - 14FFFF SA49 150000 - 157FFF SA50 158000 - 15FFFF SA51 160000 - 167FFF SA52 168000 - 16FFFF SA53 170000 - 177FFF SA54 178000 - 17FFFF SA55 180000 - 187FFF SA56 188000 - 18FFFF SA57 190000 - 197FFF SA69 1A0000 - 1A7FFF SA60 188000 - 18FFFF SA61 180000 - 18FFFF SA62 188000 - 18FFFF SA63 100000 - 107FFF SA64 180000 - 18FFFF SA65 188000 - 18FFFF SA60 189FFF SA61 180000 - 107FFF SA62 188000 - 18FFFF SA63 1C0000 - 1C7FFF SA64 1C8000 - 1CFFFF SA65 1D00000 - 1C7FFF SA66 1D00000 - 1	SA42	118000 - 11FFFF
SA45 130000 - 137FFF SA46 138000 - 13FFFF SA47 140000 - 147FFF SA48 148000 - 14FFFF SA49 150000 - 157FFF SA50 158000 - 15FFFF SA51 160000 - 167FFF SA52 168000 - 16FFFF SA53 170000 - 177FFF SA54 178000 - 17FFFF SA55 180000 - 187FFF SA56 188000 - 18FFFF SA57 190000 - 197FFF SA58 198000 - 19FFFF SA60 1A8000 - 1AFFFF SA61 180000 - 18FFFF SA62 180000 - 10FFFF SA63 100000 - 10FFFF SA64 180000 - 10FFFF SA65 180000 - 10FFFF SA60 180000 - 10FFFF SA62 180000 - 10FFFF SA63 1C00000 - 10FFFF SA64 1C8000 - 10FFFF SA65 1D0000 - 10FFFF SA66 1D0000 - 10FFFF SA67 1E0000 - 10FFFF SA68 1D	SA43	120000 - 127FFF
SA46 138000 - 13FFFF SA47 140000 - 14FFFF SA48 148000 - 14FFFF SA49 150000 - 15FFFF SA50 158000 - 15FFFF SA51 160000 - 16FFFF SA52 168000 - 16FFFF SA53 170000 - 17FFFF SA54 178000 - 18FFFF SA55 180000 - 18FFFF SA56 188000 - 18FFFF SA57 190000 - 19FFFF SA58 198000 - 19FFFF SA59 1A0000 - 1AFFFF SA60 1A8000 - 1BFFFF SA61 1B8000 - 1BFFFF SA62 1B8000 - 1BFFFF SA63 1C0000 - 1CFFFF SA64 1C8000 - 1DFFFF SA65 1D0000 - 1DFFFF SA66 1D0000 - 1DFFFF SA68 1EFFFF	SA44	128000 - 12FFFF
SA47 140000 - 147FFF SA48 148000 - 14FFFF SA49 150000 - 157FFF SA50 158000 - 15FFFF SA51 160000 - 167FFF SA52 168000 - 16FFFF SA53 170000 - 177FFF SA54 178000 - 17FFFF SA55 180000 - 187FFF SA56 188000 - 18FFFF SA57 190000 - 19FFFF SA58 198000 - 19FFFF SA59 1A0000 - 1A7FFF SA60 1A8000 - 1AFFFF SA62 1B8000 - 1BFFFF SA62 1B8000 - 1BFFFF SA63 1C0000 - 1CFFFF SA64 1C8000 - 1CFFFF SA65 1D0000 - 1DFFFF SA66 1D0000 - 1DFFFF SA66 1D0000 - 1DFFFF SA66 1D0000 - 1DFFFF SA66 1D0000 - 1DFFFF SA67 1E0000 - 1EFFFF SA68 1E8000 - 1EFFFF	SA45	130000 - 137FFF
SA48 148000 - 14FFFF SA49 150000 - 157FFF SA50 158000 - 15FFFF SA51 160000 - 167FFF SA52 168000 - 16FFFF SA53 170000 - 177FFF SA54 178000 - 17FFF SA55 180000 - 187FFF SA56 188000 - 18FFFF SA57 190000 - 197FFF SA58 198000 - 19FFFF SA60 1A8000 - 1A7FFF SA61 180000 - 187FFF SA62 188000 - 18FFFF SA63 1C0000 - 1C7FFF SA64 1C8000 - 1CFFFF SA65 1D0000 - 1D7FFF SA66 1D8000 - 1D7FFF SA67 1D0000 - 1D7FFF SA68 1D8000 - 1EFFFF SA68 1D8000 - 1EFFFF SA68 1D8000 - 1EFFFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1FFFFF	SA46	138000 - 13FFFF
SA49 150000 - 157FFF SA50 158000 - 15FFFF SA51 160000 - 167FFF SA52 168000 - 16FFFF SA53 170000 - 177FFF SA54 178000 - 17FFFF SA55 180000 - 18FFFF SA56 188000 - 18FFFF SA57 190000 - 197FFF SA58 198000 - 19FFFF SA69 1A0000 - 1A7FFF SA60 1A8000 - 18FFFF SA61 1B0000 - 1BFFFF SA62 1B8000 - 1BFFFF SA63 1C0000 - 1C7FFF SA64 1C8000 - 1CFFFF SA65 1D0000 - 1DFFFF SA66 1D0000 - 1DFFFF SA66 1D0000 - 1DFFFF SA66 1D8000 - 1DFFFF SA66 1D8000 - 1DFFFF SA67 1E0000 - 1EFFFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1FFFFF	SA47	140000 - 147FFF
SA50 158000 - 15FFFF SA51 160000 - 16FFFF SA52 168000 - 18FFFF SA53 170000 - 177FFF SA54 178000 - 17FFFF SA55 180000 - 18FFFF SA56 188000 - 18FFFF SA57 190000 - 19FFFF SA58 198000 - 19FFFF SA59 1A0000 - 1AFFFF SA60 1A8000 - 1AFFFF SA61 1B0000 - 1BFFFF SA62 1B8000 - 1BFFFF SA63 1C0000 - 1CFFFF SA64 1C8000 - 1CFFFF SA65 1D0000 - 1DFFFF SA66 1D8000 - 1DFFFF SA67 1E0000 - 1EFFFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1FFFFF	SA48	148000 - 14FFFF
SA51 160000 - 16FFFF SA52 168000 - 16FFFF SA53 170000 - 177FFF SA54 178000 - 17FFFF SA55 180000 - 187FFF SA56 188000 - 18FFFF SA57 190000 - 197FFF SA58 198000 - 19FFFF SA69 1A0000 - 1A7FFF SA60 1A8000 - 1AFFFF SA61 1B0000 - 1BFFFF SA62 1B8000 - 1BFFFF SA63 1C0000 - 1C7FFF SA64 1C8000 - 1CFFFF SA65 1D0000 - 1DFFFF SA66 1D8000 - 1DFFFF SA67 1E0000 - 1EFFFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1FFFFF	SA49	150000 - 157FFF
SA52 168000 - 16FFFF SA53 170000 - 177FFF SA54 178000 - 17FFFF SA55 180000 - 187FFF SA56 188000 - 18FFFF SA57 190000 - 197FFF SA58 198000 - 19FFFF SA59 1A0000 - 1A7FFF SA60 1A8000 - 1BFFFF SA61 1B0000 - 1BFFFF SA62 1B8000 - 1BFFFF SA63 1C0000 - 1C7FFF SA64 1C8000 - 1CFFFF SA65 1D0000 - 1D7FFF SA66 1D8000 - 1DFFFF SA67 1E0000 - 1E7FFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1FFFFF	SA50	158000 - 15FFFF
SA53 170000 - 177FFF SA54 178000 - 17FFFF SA55 180000 - 187FFF SA56 188000 - 18FFFF SA57 190000 - 197FFF SA58 198000 - 19FFFF SA59 1A0000 - 1A7FFF SA60 1A8000 - 1AFFFF SA61 1B0000 - 1B7FFF SA62 1B8000 - 1BFFFF SA63 1C0000 - 1C7FFF SA64 1C8000 - 1CFFFF SA65 1D0000 - 1D7FFF SA66 1D8000 - 1DFFFF SA67 1E0000 - 1E7FFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1F7FFF	SA51	160000 - 167FFF
SA54 178000 - 17FFFF SA55 180000 - 187FFF SA56 188000 - 18FFFF SA57 190000 - 197FFF SA58 198000 - 19FFFF SA59 1A0000 - 1A7FFF SA60 1A8000 - 18FFFF SA61 1B0000 - 1B7FFF SA62 1B8000 - 1BFFFF SA63 1C0000 - 1C7FFF SA64 1C8000 - 1CFFFF SA65 1D0000 - 1D7FFF SA66 1D8000 - 1EFFFF SA67 1E0000 - 1EFFFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1F7FFF	SA52	168000 - 16FFFF
SA55 180000 - 187FFF SA56 188000 - 18FFFF SA57 190000 - 197FFF SA58 198000 - 19FFFF SA59 1A0000 - 1A7FFF SA60 1A8000 - 1AFFFF SA61 1B0000 - 1B7FFF SA62 1B8000 - 1BFFFF SA63 1C0000 - 1C7FFF SA64 1C8000 - 1CFFFF SA65 1D0000 - 1D7FFF SA66 1D8000 - 1DFFFF SA67 1E0000 - 1E7FFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1F7FFF	SA53	170000 - 177FFF
SA56 188000 - 18FFFF SA57 190000 - 197FFF SA58 198000 - 19FFFF SA59 1A0000 - 1A7FFF SA60 1A8000 - 1AFFFF SA61 1B0000 - 1B7FFF SA62 1B8000 - 1BFFFF SA63 1C0000 - 1C7FFF SA64 1C8000 - 1CFFFF SA65 1D0000 - 1D7FFF SA66 1D8000 - 1DFFFF SA67 1E0000 - 1E7FFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1F7FFF	SA54	178000 - 17FFFF
SA57 190000 - 197FFF SA58 198000 - 19FFFF SA59 1A0000 - 1A7FFF SA60 1A8000 - 1AFFFF SA61 1B0000 - 1B7FFF SA62 1B8000 - 1BFFFF SA63 1C0000 - 1C7FFF SA64 1C8000 - 1CFFFF SA65 1D0000 - 1D7FFF SA66 1D8000 - 1DFFFF SA67 1E0000 - 1E7FFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1F7FFF	SA55	180000 - 187FFF
SA58 198000 - 19FFFF SA59 1A0000 - 1A7FFF SA60 1A8000 - 1AFFFF SA61 1B0000 - 1B7FFF SA62 1B8000 - 1BFFFF SA63 1C0000 - 1C7FFF SA64 1C8000 - 1CFFFF SA65 1D0000 - 1D7FFF SA66 1D8000 - 1DFFFF SA67 1E0000 - 1E7FFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1F7FFF	SA56	188000 - 18FFFF
SA59 1A0000 - 1A7FFF SA60 1A8000 - 1AFFFF SA61 1B0000 - 1B7FFF SA62 1B8000 - 1BFFFF SA63 1C0000 - 1C7FFF SA64 1C8000 - 1CFFFF SA65 1D0000 - 1D7FFF SA66 1D8000 - 1DFFFF SA67 1E0000 - 1E7FFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1F7FFF	SA57	190000 - 197FFF
SA60 1A8000 - 1AFFFF SA61 1B0000 - 1BFFFF SA62 1B8000 - 1BFFFF SA63 1C0000 - 1CFFFF SA64 1C8000 - 1CFFFF SA65 1D0000 - 1DFFFF SA66 1D8000 - 1DFFFF SA67 1E0000 - 1EFFFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1FFFFF	SA58	198000 - 19FFFF
SA61 1B0000 - 1B7FFF SA62 1B8000 - 1BFFFF SA63 1C0000 - 1C7FFF SA64 1C8000 - 1CFFFF SA65 1D0000 - 1D7FFF SA66 1D8000 - 1DFFFF SA67 1E0000 - 1E7FFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1F7FFF	SA59	1A0000 - 1A7FFF
SA62 1B8000 - 1BFFFF SA63 1C0000 - 1C7FFF SA64 1C8000 - 1CFFFF SA65 1D0000 - 1D7FFF SA66 1D8000 - 1DFFFF SA67 1E0000 - 1E7FFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1F7FFF	SA60	1A8000 - 1AFFFF
SA63 1C0000 - 1C7FFF SA64 1C8000 - 1CFFFF SA65 1D0000 - 1D7FFF SA66 1D8000 - 1DFFFF SA67 1E0000 - 1E7FFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1F7FFF	SA61	1B0000 - 1B7FFF
SA64 1C8000 - 1CFFFF SA65 1D0000 - 1D7FFF SA66 1D8000 - 1DFFFF SA67 1E0000 - 1E7FFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1F7FFF	SA62	1B8000 - 1BFFFF
SA65 1D0000 - 1D7FFF SA66 1D8000 - 1DFFFF SA67 1E0000 - 1E7FFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1F7FFF	SA63	1C0000 - 1C7FFF
SA66 1D8000 - 1DFFFF SA67 1E0000 - 1E7FFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1F7FFF	SA64	1C8000 - 1CFFFF
SA67 1E0000 - 1E7FFF SA68 1E8000 - 1EFFFF SA69 1F0000 - 1F7FFF	SA65	1D0000 - 1D7FFF
SA68 1E8000 - 1EFFFF SA69 1F0000 -1F7FFF	SA66	1D8000 - 1DFFFF
SA69 1F0000 -1F7FFF	SA67	1E0000 - 1E7FFF
	SA68	1E8000 - 1EFFFF
SA70 1F8000 - 1FFFF	SA69	1F0000 -1F7FFF
	SA70	1F8000 - 1FFFF





Top Boot – Sector Address Table

	x16
Sector	Address Range (A20 - A0)
SA0	00000 - 07FFF
SA1	08000 - 0FFFF
SA2	10000 - 17FFF
SA3	18000 - 1FFFF
SA4	20000 - 27FFF
SA5	28000 - 2FFFF
SA6	30000 - 37FFF
SA7	38000 - 3FFFF
SA8	40000 - 47FFF
SA9	48000 - 4FFFF
SA10	50000 - 57FFF
SA11	58000 - 5FFFF
SA12	60000 - 67FFF
SA13	68000 - 6FFFF
SA14	70000 - 77FFF
SA15	78000 - 7FFFF
SA16	80000 - 87FFF
SA17	88000 - 8FFFF
SA18	90000 - 97FFF
SA19	98000 - 9FFFF
SA20	A0000 - A7FFF
SA21	A8000 - AFFFF
SA22	B0000 - B7FFF
SA23	B8000 - BFFFF
SA24	C0000 - C7FFF
SA25	C8000 - CFFFF
SA26	D0000 - D7FFF
SA27	D8000 - DFFFF
SA28	E0000 - E7FFF
SA29	E8000 - EFFFF
SA30	F0000 - F7FFF
SA31	F8000 - FFFFF
SA32	100000 - 107FFF
SA33	108000 - 10FFFF
SA34	110000 - 117FFF
SA35	118000 - 11FFFF
SA36	120000 - 127FFF

Top Boot – Sector Address Table (Continued)

	x16
Sector	Address Range (A20 - A0)
SA37	128000 - 12FFFF
SA38	130000 - 137FFF
SA39	138000 - 13FFFF
SA40	140000 - 147FFF
SA41	148000 - 14FFFF
SA42	150000 - 157FFF
SA43	158000 - 15FFFF
SA44	160000 - 167FFF
SA45	168000 - 16FFFF
SA46	170000 - 177FFF
SA47	178000 - 17FFFF
SA48	180000 - 187FFF
SA49	188000 - 18FFFF
SA50	190000 - 197FFF
SA51	198000 - 19FFFF
SA52	1A0000 - 1A7FFF
SA53	1A8000 - 1AFFFF
SA54	1B0000 - 1B7FFF
SA55	1B8000 - 1BFFFF
SA56	1C0000 - 1C7FFF
SA57	1C8000 - 1CFFFF
SA58	1D0000 - 1D7FFF
SA59	1D8000 - 1DFFFF
SA60	1E0000 - 1E7FFF
SA61	1E8000 - 1EFFFF
SA62	1F0000 - 1F7FFF
SA63	1F8000 - 1F8FFF
SA64	1F9000 - 1F9FFF
SA65	1FA000 - 1FAFFF
SA66	1FB000 - 1FBFFF
SA67	1FC000 - 1FCFFF
SA68	1FD000 - 1FDFFF
SA69	1FE000 - 1FEFFF
SA70	1FF000 - 1FFFFF





DC and AC Operating Range

		32-Mbit Flash
Operating Temperature (Case)	Ind.	-40°C - 85°C
V _{CC} Power Supply		2.7V to 3.6V

Operating Modes

Mode	CE	OE	WE	RESET	V_{PP}	Ai	I/O
Read	V_{IL}	V_{IL}	V _{IH}	V _{IH}	Х	Ai	D _{OUT}
Program/Erase ⁽²⁾	V_{IL}	V _{IH}	V _{IL}	V _{IH}	V _{IHPP} ⁽⁶⁾	Ai	D _{IN}
Standby/Program Inhibit	V _{IH}	X ⁽¹⁾	Х	V _{IH}	Х	Х	High-Z
	Х	Х	V _{IH}	V _{IH}	Х		
Program Inhibit	Х	V _{IL}	Х	V _{IH}	Х		
	Х	Х	Х	V _{IH}	V _{ILPP} ⁽⁷⁾		
Output Disable	Х	V _{IH}	Х	V _{IH}	Х		High-Z
Reset	Х	Х	Х	V _{IL}	Х	Х	High-Z
Product Identification							
		.,	.,	.,		A1 - A20 = V _{IL} , A9 = V _H ⁽³⁾ , A0 = V _{IL}	Manufacturer Code ⁽⁴⁾
Hardware	V _{IL}	V_{IL}	V _{IH}	V _{IH}		A1 - A20 = V _{IL} , A9 = V _H ⁽³⁾ , A0 = V _{IH}	Device Code ⁽⁴⁾
O = (1)				.,		A0 = V _{IL} , A1 - A20 = V _{IL}	Manufacturer Code ⁽⁴⁾
Software ⁽⁵⁾				V _{IH}		A0 = V _{IH} , A1 - A20 = V _{IL}	Device Code ⁽⁴⁾

- Notes: 1. X can be V_{IL} or V_{IH} .
 - 2. Refer to AC programming waveforms on page 25.
 - 3. $V_H = 12.0V \pm 0.5V$.
 - 4. Manufacturer Code: 001FH (x16), Device Code: 00C8H (x16)-Bottom Boot; 00C9H (x16)-Top Boot.
 - 5. See details under "Software Product Identification Entry/Exit" on page 27.
 - 6. V_{IHPP} (min) = 0.9V; V_{IHPP} (max) = 3.6V.
 - 7. V_{ILPP} (max) = 0.4V.

DC Characteristics

Symbol	Parameter	Condition	Min	Тур	Max	Units
ILI	Input Load Current	V _{IN} = 0V to V _{CC}			10	μΑ
I _{LO}	Output Leakage Current	V _{I/O} = 0V to V _{CC}			10	μΑ
I _{SB}	V _{CC} Standby Current CMOS	$\overline{\text{CE}} = \text{V}_{\text{CC}} - 0.3 \text{V to V}_{\text{CC}}$		13	25	μΑ
I _{CC} ⁽¹⁾	V _{CC} Active Read Current	f = 5 MHz; I _{OUT} = 0 mA		12	25	mA
I _{CC1}	V _{CC} Programming Current				45	mA
I _{PP1}	V _{PP} Input Load Current				10	μA
V _{IL}	Input Low Voltage				0.6	V
V _{IH}	Input High Voltage		2.0			V
V _{OL1}	Output Low Voltage	I _{OL} = 2.1 mA			0.45	V
V _{OL2}	Output Low Voltage	I _{OL} = 1.0 mA			0.20	V
V _{OH1}	Output High Voltage	I_{OH} = -400 μA V_{CCQ} < 2.6V I_{OH} = -400 μA V_{CCQ} ≥ 2.6V I_{OH} = -400 μA	V _{CCQ} - 0.2 2.4 2.4			V V V
V _{OH2}	Output High Voltage	I_{OH} = -100 μA V_{CCQ} < 2.6V I_{OH} = -100 μA V_{CCQ} ≥ 2.6V I_{OH} = -100 μA	V _{CCQ} - 0.1 2.5 2.5			V V V

Note: 1. In the erase mode, I_{CC} is 65 mA.

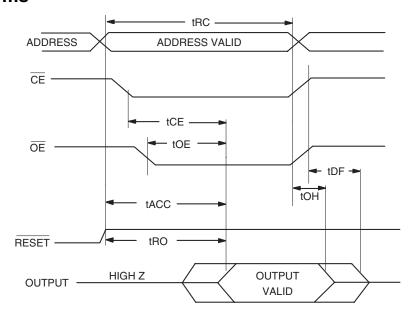




AC Read Characteristics

		32-Mbit Flash		
Symbol	Parameter	Min	Max	Units
t _{RC}	Read Cycle Time		70	ns
t _{ACC}	Address to Output Delay		70	ns
t _{CE} ⁽¹⁾	CE to Output Delay		70	ns
t _{OE} ⁽²⁾	OE to Output Delay	0	40	ns
t _{DF} ⁽³⁾⁽⁴⁾	CE or OE to Output Float	0	25	ns
t _{OH}	Output Hold from OE, CE or Address, whichever occurred first	0		ns
t _{RO}	RESET to Output Delay		100	ns

AC Read Waveforms⁽¹⁾⁽²⁾⁽³⁾⁽⁴⁾



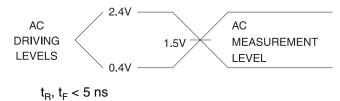
- Notes: 1. \overline{CE} may be delayed up to t_{ACC} t_{CE} after the address transition without impact on t_{ACC} .

 2. \overline{OE} may be delayed up to t_{CE} t_{OE} after the falling edge of \overline{CE} without impact on t_{CE} or by t_{ACC} t_{OE} after an address change without impact on t_{ACC}.

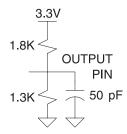
 3. t_{DF} is specified from OE or CE, whichever occurs first (CL = 5 pF).

 4. This parameter is characterized and is not 100% tested.

Input Test Waveforms and Measurement Level



Output Test Load



Pin Capacitance

 $f = 1 \text{ MHz}, T = 25^{\circ}C^{(1)}$

Symbol	Тур	Max	Units	Conditions
C _{IN}	4	6	pF	$V_{IN} = 0V$
C _{OUT}	8	12	pF	V _{OUT} = 0V

Note: This parameter is characterized and is not 100% tested.

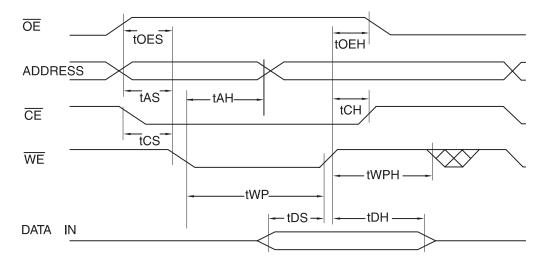


AC Word Load Characteristics

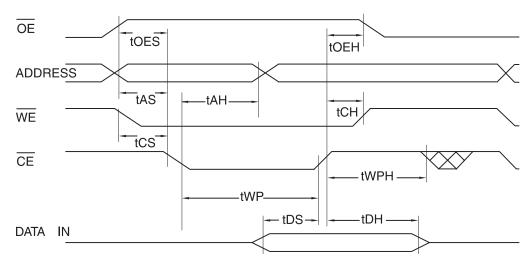
Symbol	Parameter	Min	Max	Units
t _{AS} , t _{OES}	Address, OE Setup Time	0		ns
t _{AH}	Address Hold Time	35		ns
t _{CS}	Chip Select Setup Time	0		ns
t _{CH}	Chip Select Hold Time	0		ns
t _{WP}	Write Pulse Width (WE or CE)	35		ns
t _{DS}	Data Setup Time	35		ns
t _{DH} , t _{OEH}	Data, $\overline{\text{OE}}$ Hold Time	0		ns
t _{WPH}	Write Pulse Width High	35		ns

AC Word Load Waveforms

WE Controlled



CE Controlled



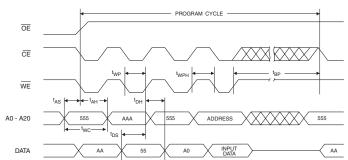
AT52BR3224A(T)/3228A(T)

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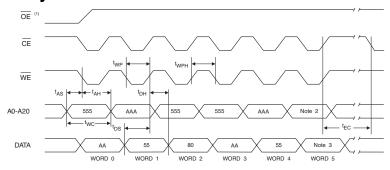
Program Cycle Characteristics

Symbol	Parameter	Min	Тур	Max	Units
t _{BP}	Word Programming Time		15	150	μs
t _{AS}	Address Setup Time	0			ns
t _{AH}	Address Hold Time	35			ns
t _{DS}	Data Setup Time	35			ns
t _{DH}	Data Hold Time	0			ns
t _{WP}	Write Pulse Width	35			ns
t _{WPH}	Write Pulse Width High	35			ns
t _{WC}	Write Cycle Time	70			ns
t _{RP}	Reset Pulse Width	500			ns
t _{EC}	Chip Erase Cycle Time		80	400	seconds
t _{SEC1}	Sector Erase Cycle Time (4K Word Sectors)		0.3	3.0	seconds
t _{SEC2}	Sector Erase Cycle Time (32K Word Sectors)		1.2	5.0	seconds
t _{ES}	Erase Suspend Time			15	μs
t _{PS}	Program Suspend Time			20	μs

Program Cycle Waveforms



Sector or Chip Erase Cycle Waveforms



Notes: 1. \overline{OE} must be high only when \overline{WE} and \overline{CE} are both low.

- 2. For chip erase, the address should be 555. For sector erase, the address depends on what sector is to be erased. (See note 3 under "Command Definitions in Hex" on page 14.)
- 3. For chip erase, the data should be 10H, and for sector erase, the data should be 30H.





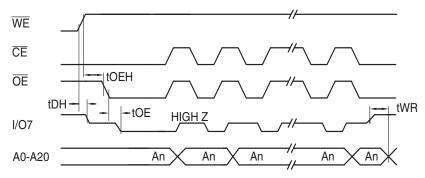
Data Polling Characteristics (1)

Symbol	Parameter	Min	Тур	Max	Units
t _{DH}	Data Hold Time	10			ns
t _{OEH}	OE Hold Time	10			ns
t _{OE}	ŌĒ to Output Delay ⁽²⁾				ns
t _{WR}	Write Recovery Time	0			ns

Notes: 1. These parameters are characterized and not 100% tested.

2. See t_{OE} spec in "AC Read Characteristics" on page 22.

Data Polling Waveforms



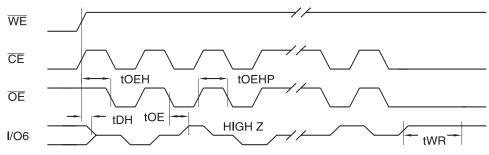
Toggle Bit Characteristics⁽¹⁾

Symbol	Parameter	Min	Тур	Max	Units
t _{DH}	Data Hold Time	10			ns
t _{OEH}	OE Hold Time	10			ns
t _{OE}	OE to Output Delay ⁽²⁾				ns
t _{OEHP}	OE High Pulse	50			ns
t _{WR}	Write Recovery Time	0			ns

Notes: 1. These parameters are characterized and not 100% tested.

2. See t_{OE} spec in "AC Read Characteristics" on page 22.

Toggle Bit Waveforms⁽¹⁾⁽²⁾⁽³⁾



Notes: 1. Toggling either \overline{OE} or \overline{CE} or both \overline{OE} and \overline{CE} will operate toggle bit. The t_{OEHP} specification must be met by the toggling input(s).

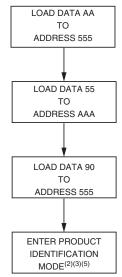
2. Beginning and ending state of I/O6 will vary.

3. Any address location may be used but the address should not vary.

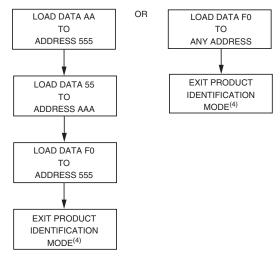
AT52BR3224A(T)/3228A(T)

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Software Product Identification Entry⁽¹⁾



Software Product Identification Exit⁽¹⁾⁽⁶⁾



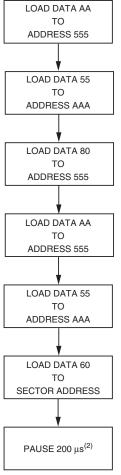
Notes:

- Data Format: I/O15 I/O8 (Don't Care); I/O7 I/O0 (Hex) Address Format: A11 - A0 (Hex), and A11 - A20 (Don't Care).
- 2. A1 A20 = V_{IL} . Manufacturer Code is read for A0 = V_{IL} ; Device Code is read for A0 = V_{IH} .
- The device does not remain in identification mode if powered down.
- 4. The device returns to standard operation mode.
- 5. Manufacturer Code: 001FH(x16)

Device Code: 00C8 (x16)-Bottom Boot 00C9H (x16)-Top Boot.

6. Either one of the Product ID Exit commands can be used.

Sector Lockdown Enable Algorithm⁽¹⁾



Notes:

- Data Format: I/O15 I/O8 (Don't Care); I/O7 I/O0 (Hex) Address Format: A11 - A0 (Hex), A-1, and A11 - A20 (Don't Care).
- 2. Sector Lockdown feature enabled.



4-megabit SRAM Description

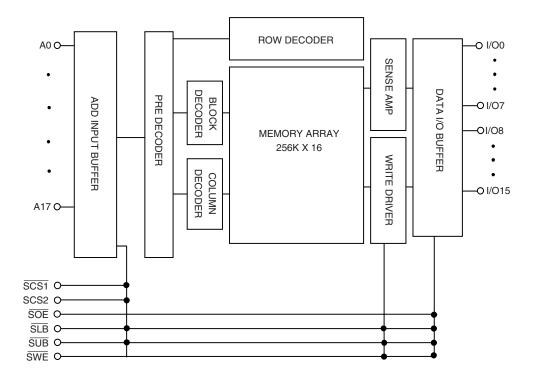
The 4-megabit SRAM is a high-speed, super low-power CMOS SRAM organized as 256K words by 16 bits. The SRAM uses high-performance full CMOS process technology and is designed for high-speed and low-power circuit technology. It is particularly well-suited for the high-density low-power system application. This device has a data retention mode that guarantees data to remain valid at a minimum power supply voltage of 1.2V.

Features

- Fully Static Operation and Tri-state Output
- TTL Compatible Inputs and Outputs
- Battery Backup
 - 1.2V (Min) Data Retention

Voltage (V)	Speed (ns)	Operation Current/I _{CC} (mA) (Max)	Standby Current (µA) (Max)	Temperature (° C)
2.7 - 3.3	70	3	10	-40 - 85

Block Diagram



Absolute Maximum Ratings(1)

Symbol	Parameter	Rating	Unit
V _{IN} , V _{OUT}	Input/Output Voltage	-0.3 to 3.6	V
V _{CC}	Power Supply	-0.3 to 4.6	V
T _A	Operating Temperature	-40 to 85	°C
T _{STG}	Storage Temperature	-55 to 150	°C
P _D	Power Dissipation	1.0	W

Note: 1. Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is stress rating only and the functional operation of the device under these or any other conditions above those indicated in the operation of this specification is not implied. Exposure to the absolute maximum rating conditions for extended period may affect reliability.

Truth Table

							I/O	Pin	
SCS1	SCS2	SWE	SOE	SLB ⁽²⁾	SUB ⁽²⁾	Mode	I/O0 - I/O7	I/O8 - I/O15	Power
H ⁽¹⁾	Х			V	V				
X ⁽¹⁾	L	Х	X	X	X	Deselected	High-Z	High-Z	Standby
Х	Х			Н	Н				
				L	Н				
L ⁽¹⁾	Н	Н	Н	Н	L	Output Disabled	High-Z	High-Z	Active
				L	L				
				L	Н		D _{IN}	High-Z	
L	Н	L	Х	Н	L	Write	High-Z	D _{IN}	A ativo
L	п	L	^			vviile	D _{IN}	D _{IN}	Active
				L	L		D _{IN}	High-Z	
				L	Н		D _{OUT}	High-Z	
	Н	Н	L	Н	L	Read	High-Z	D _{OUT}	Active
	п	П	L			nead	D _{OUT}	D _{OUT}	Active
				L	L		D _{OUT}	High-Z	

Notes: 1. $H = V_{IH}, L = V_{IL}, X = Don't Care (V_{IL} or V_{IH})$ 2. $\overline{SUB}, \overline{SLB}$ (Upper, Lower Byte Enable). These active LOW inputs allow individual bytes to be written or read. When \overline{SLB} is LOW, data is written or read to the lower byte, I/O0 - I/O7. When SUB is LOW, data is written or read to the upper byte, I/O8 - I/O15.

Recommended DC Operating Condition

Symbol	Parameter	Min	Тур	Max	Unit
V _{CC}	Supply Voltage	2.7	3.0	3.3	V
V _{SS}	Ground	0	0	0	V
V _{IH}	Input High Voltage	2.2		V _{CC} + 0.3	V
V _{IL} ⁽¹⁾	Input Low Voltage	-0.3 ⁽¹⁾		0.6	V

1. Undershoot: $V_{IL} = -1.5V$ for pulse width less than 30 ns. Undershoot is sampled, not 100% tested. Note:





DC Electrical Characteristics

 $T_A = -40^{\circ}\,C$ to $85^{\circ}\,C$

Symbol	Parameter	Test Condition	Min	Max	Unit
I _{LI}	Input Leakage Current	$V_{SS} < V_{IN} < V_{CC}$	-1	1	μΑ
I _{LO}	Output Leakage Current	$\begin{split} & \frac{V_{SS} < V_{OUT} < V_{CC},}{\overline{SCS1} = V_{IH} \text{ or } SCS2 = V_{IL} \text{ or } \overline{SOE} = V_{IH} \text{ or } \overline{SWE} = VIL \text{ or } \overline{SUB} = V_{IH}, \overline{SLB} = V_{IH} \end{split}$	-1	1	μА
I _{cc}	Operating Power Supply Current	$\overline{SCS1} = V_{IL}, SCS2=V_{IH},$ $V_{IN} = V_{IH} \text{ or } V_{IL}, I_{I/O} = 0 \text{ mA}$		3	mA
I _{CC1}	Average Operating Current			15	mA
		$\overline{SCS1}$ < 0.2V, SCS2 > V _{CC} - 0.2V V _{IN} < 0.2V or V _{IN} > V _{CC} - 0.2V, Cycle Time = 1 μ s 100% Duty, I _{I/O} = 0 mA		2	mA
I _{SB}	Standby Current (TTL Input)	$\overline{\frac{SCS1}{SUB}} = V_{IH} \text{ or } SCS2 = V_{IL} \text{ or } SUB, \overline{SLB} = V_{IH}$ $V_{IN} = V_{IH} \text{ or } V_{IL}$		300	μА
I _{SB1}	Standby Current (CMOS Input)			10	μА
V _{OL}	Output Low	I _{OL} = 2.1 mA		0.4	V
V _{OH}	Output High	I _{OH} = -1.0 mA	2.4		V

Capacitance⁽¹⁾

 $(Temp = 25^{\circ} C, f = 1.0 MHz)$

Symbol	Parameter	Condition	Max	Unit
C _{IN}	Input Capacitance (Add, SCS1, SCS2, SLB, SUB, SWE, SOE)	V _{IN} = 0 V	8	pF
C _{OUT}	Output Capacitance (I/O)	V _{I/O} = 0 V	10	pF

Note: 1. These parameters are sampled and not 100% tested.

AC Characteristics

 $T_A = -40^{\circ} \, \text{C}$ to $85^{\circ} \, \text{C}$, Unless Otherwise Specified

			70	ns	
#	Symbol	Parameter	Min	Max	Unit
1	t _{RC}	Read Cycle Time	70		ns
2	t _{AA}	Address Access Time		70	ns
3	t _{ACS}	Chip Select Access Time		70	ns
4	t _{OE}	Output Enable to Output Valid		35	ns
5	t _{BA}	SLB, SUB Access Time		70	ns
6	t _{CLZ}	Chip Select to Output in Low Z	10		ns
7	t _{OLZ}	Output Enable to Output in Low Z	5		ns
8	t _{BLZ}	SLB, SUB Enable to Output in Low Z	10		ns
9	t _{CHZ}	Chip Deselection to Output in High Z	0	25	ns
10	t _{OHZ}	Out Disable to Output in High Z	0	25	ns
11	t _{BHZ}	SLB, SUB Disable to Output in High Z	0	25	ns
12	t _{OH}	Output Hold from Address Change	10		ns
13	t _{WC}	Write Cycle Time	30		ns
14	t _{CW}	Chip Selection to End of Write	30		ns
15	t _{AW}	Address Valid to End of Write	30		ns
16	t _{BW}	SLB, SUB Valid to End of Write	30		ns
17	t _{AS}	Address Setup Time	0		ns
18	t _{WP}	Write Pulse Width	30		ns
19	t _{WR}	Write Recovery Time	0		ns
20	t _{WHZ}	Write to Output in High Z	0	20	ns
21	t _{DW}	Data to Write Time Overlap	20		ns
22	t _{DH}	Data Hold from Write Time	0		ns
23	t _{OW}	Output Active from End of Write	5		ns

AC Test Conditions

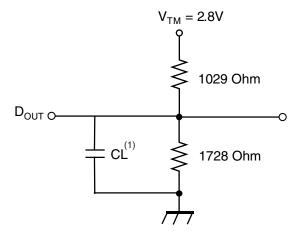
TA = -40° C to 85° C, Unless Otherwise Specified

Parameter		Value
Input Pulse Level		0.4V to 2.2V
Input Rise and Fall	Time	5 ns
Input and Output T	iming Reference Level	1.5V
Output Load	$t_{\text{CLZ}}, t_{\text{OLZ}}, t_{\text{BLZ}}, t_{\text{CHZ}}, t_{\text{OHZ}}, t_{\text{BHZ}}, t_{\text{WHZ}}, t_{\text{OW}}$	CL = 5 pF + 1 TTL Load
	Others	CL = 30 pF + 1 TTL Load





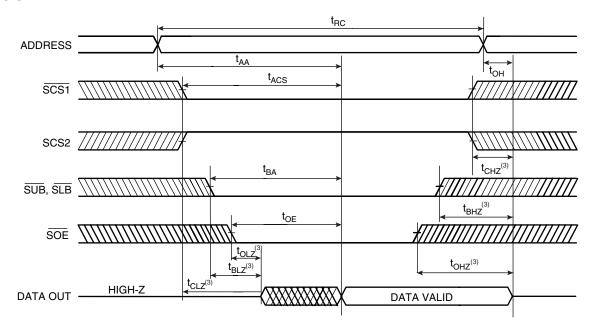
AC Test Loads



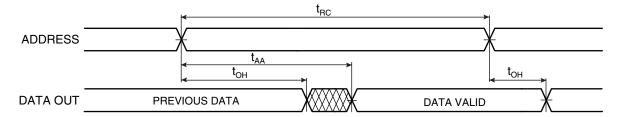
Note: Including jig and scope capacitance.

Timing Diagrams

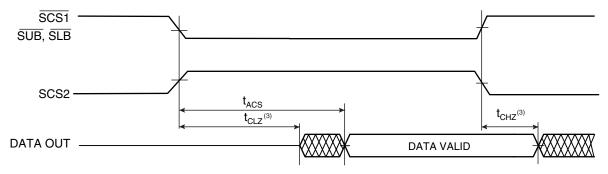
Read Cycle 1^{(1),(4)}



Read Cycle 2^{(1),(2),(4)}



Read Cycle 3^{(1),(2),(4)}



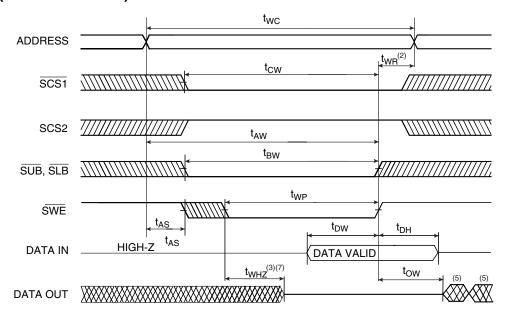
Notes:

- 1. Read Cycle occurs whenever a high on the SWE and SOE is low, while SUB and/or SLB and SCS1 and SCS2 are in active status.
- 2. SOE = V_{\parallel}
- 3. Transition is measured \pm 200 mV from steady state voltage. This parameter is sampled and not 100% tested.
- 4. SCS1 in high for the standby, low for active. SCS2 in low for the standby, high for active. SUB and SLB in high for the standby, low for active.

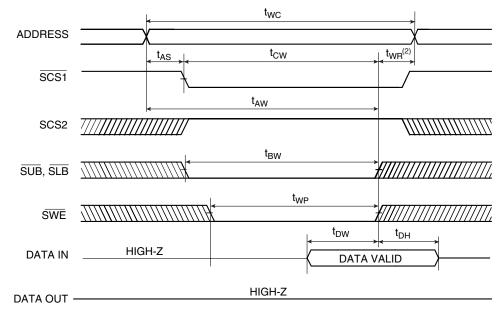




Write Cycle 1 (SWE Controlled)(1),(4),(8)



Write Cycle 2 (SCS1, SCS2 Controlled)(1),(4),(8)



- Notes: 1. A write occurs during the overlap of a low SWE, a low SCS1, a high SCS2 and a low SUB and/or SLB.
 - 2. t_{WB} is measured from the earlier of SCS1, SLB, SUB, or SWE going high or SCS2 going low to the end of write cycle.
 - 3. During this period, I/O pins are in the output state so that the input signals of opposite phase to the output must not be applied.
 - 4. If the SCS1, SLB and SUB low transition and SCS2 high transition occur simultaneously with the SWE low transition or after the SWE transition, outputs remain in a high impedance state.
 - 5. Q (data out) is the same phase with the write data of this write cycle.
 - 6. Q (data out) is the read data of the next address.
 - 7. Transition is measured ± 200 mV from steady state. This parameter is sampled and not 100% tested.
 - 8. SCS1 in high for the standby, low for active SCS2 in low for the standby, high for active. SUB and SLB in high for the standby, low for active.

Data Retention Electric Characteristic

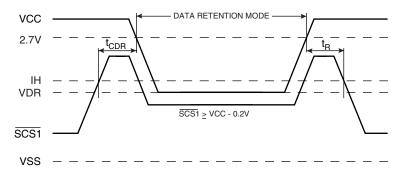
 $T_A = -40^{\circ} \, C$ to $85^{\circ} \, C$

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
V _{DR}	V _{CC} for Data Retention	$\begin{split} \overline{SCS1} &> V_{CC} - 0.2V \text{ or} \\ SCS2 &< V_{SS} + 0.2V \text{ or} \\ \overline{SUB}, \overline{SLB} &> V_{CC} - 0.2V \\ V_{IN} &> V_{CC} - 0.2V \text{ or} \\ V_{IN} &< V_{SS} + 0.2V \end{split}$	1.2		3.3	٧
I _{CCDR}	Data Retention Current			0.2	6	μА
t _{CDR}	Chip Deselect to Data Retention Time	See Data Retention Timing Diagram	0			ns
t _R	Operating Recovery Time		t _{RC}			ns

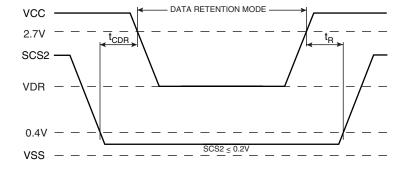
Notes: 1. Typical values are under the condition of $T_A = 25^{\circ}$ C. Typical values are sampled and not 100% tested.

2. t_{RC} is read cycle time.

Data Retention Timing Diagram 1



Data Retention Timing Diagram 2







8-megabit SRAM Description

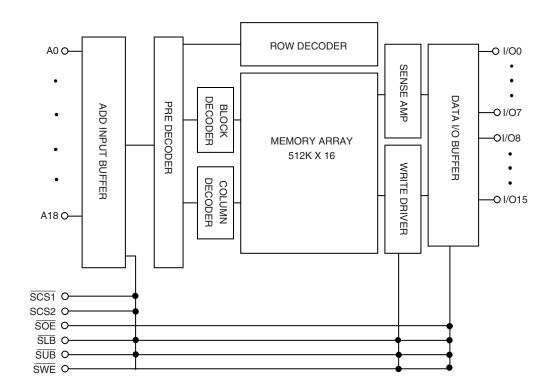
The 8-megabit SRAM is a high-speed, super low-power CMOS SRAM organized as 512K words by 16 bits. The SRAM uses high-performance full CMOS process technology and is designed for high-speed and low-power circuit technology. It is particularly well-suited for the high-density low-power system application. This device has a data retention mode that guarantees data to remain valid at a minimum power supply voltage of 1.2V.

Features

- Fully Static Operation and Tri-state Output
- TTL Compatible Inputs and Outputs
- Battery Backup
 - 1.2V (Min) Data Retention

Voltage (V)	Speed (ns)	Operation Current/I _{CC} (mA) (Max)	Standby Current (µA) (Max)	Temperature (° C)
2.7 - 3.3	70	3	15	-40 - 85

Block Diagram



Absolute Maximum Ratings(1)

Symbol	Parameter	Rating	Unit
V _{IN} , V _{OUT}	Input/Output Voltage	-0.3 to 3.6	V
V _{CC}	Power Supply	-0.3 to 4.6	V
T _A	Operating Temperature	-40 to 85	°C
T _{STG}	Storage Temperature	-55 to 150	°C
P_{D}	Power Dissipation	1.0	W

Note:

1. Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is stress rating only and the functional operation of the device under these or any other conditions above those indicated in the operation of this specification is not implied. Exposure to the absolute maximum rating conditions for extended period may affect reliability.

Truth Table

							I/O	Pin							
SCS1	SCS2	SWE	SOE	SLB ⁽²⁾	SUB ⁽²⁾	Mode	I/O0 - I/O7	I/O8 - I/O15	Power						
H ⁽¹⁾	Х			Х	Х										
X ⁽¹⁾	L	X	Х	^	^	Deselected	High-Z	High-Z	Standby						
Х	Х			Н	Н										
				L	Н										
L ⁽¹⁾	Н	Н	Н	Н	L	Output Disabled	High-Z	High-Z	Active						
				L	L										
										L	Н		D _{IN}	High-Z	
L	Н		X	Н	L	Write	High-Z	D _{IN}	Antico						
L	П	L						D _{IN}	D _{IN}	Active					
				L	L		D _{IN}	High-Z							
				L	Н		D _{OUT}	High-Z							
	Н	Н		Н	L	Dood	Dard	High-Z	D _{OUT}	A ations					
L	П	П	L			Read	D _{OUT}	D _{OUT}	Active						
				L	L		D _{OUT}	High-Z							

- Notes: 1. $H = V_{IH}$, $L = V_{IL}$, $X = Don't Care (V_{IL} or V_{IH})$
 - 2. SUB, SLB (Upper, Lower Byte Enable). These active LOW inputs allow individual bytes to be written or read. When SLB is LOW, data is written or read to the lower byte, I/O0 - I/O7. When SUB is LOW, data is written or read to the upper byte, I/O8 - I/O15.

Recommended DC Operating Condition

Symbol	Parameter	Min	Тур	Max	Unit
V _{CC}	Supply Voltage	2.7	3.0	3.3	V
V _{SS}	Ground	0	0	0	V
V _{IH}	Input High Voltage	2.2		V _{CC} + 0.3	V
V _{IL} ⁽¹⁾	Input Low Voltage	-0.3 ⁽¹⁾		0.6	V

1. Undershoot: $V_{II} = -1.5V$ for pulse width less than 30 ns. Undershoot is sampled, not 100% tested.





DC Electrical Characteristics

 $T_A = -40^{\circ}\,C$ to $85^{\circ}\,C$

Symbol	Parameter	Test Condition	Min	Max	Unit
ILI	Input Leakage Current	V _{SS} < V _{IN} < V _{CC}	-1	1	μΑ
I _{LO}	Output Leakage Current	$\begin{split} & \frac{V_{SS} < V_{OUT} < V_{CC},}{\overline{SCS1} = V_{IH} \text{ or } SCS2 = V_{IL} \text{ or } } \\ & \overline{SOE} = V_{IH} \text{ or } \overline{SWE} = VIL \text{ or } \\ & \overline{SUB} = V_{IH}, \overline{SLB} = V_{IH} \end{split}$	-1	1	μА
I _{CC}	Operating Power Supply Current	$\overline{SCS1} = V_{IL}, SCS2=V_{IH},$ $V_{IN} = V_{IH} \text{ or } V_{IL}, I_{I/O} = 0 \text{ mA}$		3	mA
I _{CC1}	Average Operating Current			15	mA
				2	mA
I _{SB}	Standby Current (TTL Input)			0.3	mA
I _{SB1}	Standby Current (CMOS Input)	$\begin{split} \overline{SCS1} &> V_{CC} - 0.2V \text{ or} \\ SCS2 &< V_{SS} + 0.2V \text{ or} \\ \overline{SUB}, \overline{SLB} &> V_{CC} - 0.2V \\ V_{IN} &> V_{CC} - 0.2V \text{ or} \\ V_{IN} &< V_{SS} + 0.2V \end{split}$		15	μА
V _{OL}	Output Low	I _{OL} = 2.1 mA		0.4	V
V _{OH}	Output High	I _{OH} = -1.0 mA	2.4		V

Capacitance⁽¹⁾

 $(Temp = 25^{\circ} C, f = 1.0 MHz)$

Symbol	Parameter	Condition	Max	Unit
C _{IN}	Input Capacitance (Add, SCS1, SCS2, SLB, SUB, SWE, SOE)	V _{IN} = 0 V	8	pF
C _{OUT}	Output Capacitance (I/O)	V _{I/O} = 0 V	10	pF

Note: 1. These parameters are sampled and not 100% tested.

AC Characteristics

 $T_A = -40^{\circ} \, \text{C}$ to $85^{\circ} \, \text{C}$, Unless Otherwise Specified

	Symbol		70 ns			
#		Parameter	Min	Min Max		
1	t _{RC}	Read Cycle Time	70		ns	
2	t _{AA}	Address Access Time		70	ns	
3	t _{ACS}	Chip Select Access Time		70	ns	
4	t _{OE}	Output Enable to Output Valid		35	ns	
5	t _{BA}	SLB, SUB Access Time		70	ns	
6	t _{CLZ}	Chip Select to Output in Low Z	10		ns	
7	t _{OLZ}	Output Enable to Output in Low Z	5		ns	
8	t _{BLZ}	SLB, SUB Enable to Output in Low Z	10		ns	
9	t _{CHZ}	Chip Deselection to Output in High Z	0	25	ns	
10	t _{OHZ}	Out Disable to Output in High Z	0	25	ns	
11	t _{BHZ}	SLB, SUB Disable to Output in High Z	0	25	ns	
12	t _{OH}	Output Hold from Address Change	10		ns	
13	t _{WC}	Write Cycle Time	70		ns	
14	t _{CW}	Chip Selection to End of Write	60		ns	
15	t _{AW}	Address Valid to End of Write	60		ns	
16	t _{BW}	SLB, SUB Valid to End of Write	60		ns	
17	t _{AS}	Address Setup Time	0		ns	
18	t _{WP}	Write Pulse Width	50		ns	
19	t _{WR}	Write Recovery Time	0		ns	
20	t _{WHZ}	Write to Output in High Z	0	20	ns	
21	t _{DW}	Data to Write Time Overlap	30		ns	
22	t _{DH}	Data Hold from Write Time	0		ns	
23	t _{OW}	Output Active from End of Write	5		ns	

AC Test Conditions

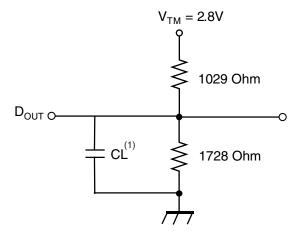
 $TA = -40^{\circ} C$ to $85^{\circ} C$, Unless Otherwise Specified

Parameter		Value
Input Pulse Level		0.4V to 2.2V
Input Rise and Fall Time		5 ns
Input and Output Timing Reference Level		1.5V
Output Load	$t_{\text{CLZ}},t_{\text{OLZ}},t_{\text{BLZ}},t_{\text{CHZ}},t_{\text{OHZ}},t_{\text{BHZ}},t_{\text{WHZ}},t_{\text{OW}}$	CL = 5 pF + 1 TTL Load
	Others	CL = 30 pF + 1 TTL Load





AC Test Loads

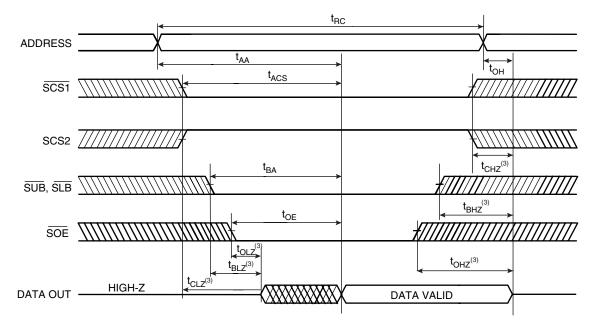


Note: Including jig and scope capacitance.

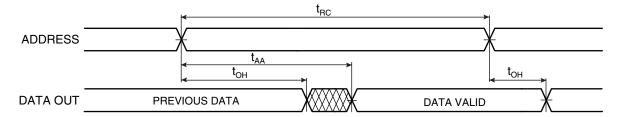
40

Timing Diagrams

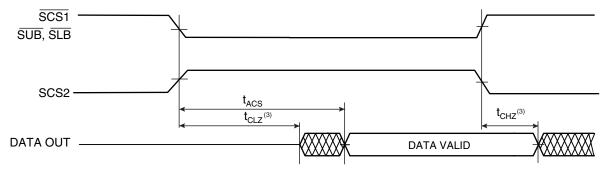
Read Cycle 1^{(1),(4)}



Read Cycle 2^{(1),(2),(4)}



Read Cycle 3^{(1),(2),(4)}



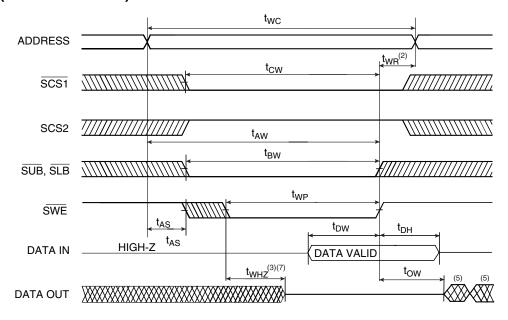
Notes:

- 1. Read Cycle occurs whenever a high on the SWE and SOE is low, while SUB and/or SLB and SCS1 and SCS2 are in active status.
- 2. $\overline{SOE} = V_{II}$
- 3. Transition is measured \pm 200 mV from steady state voltage. This parameter is sampled and not 100% tested.
- 4. SCS1 in high for the standby, low for active. SCS2 in low for the standby, high for active. SUB and SLB in high for the standby, low for active.

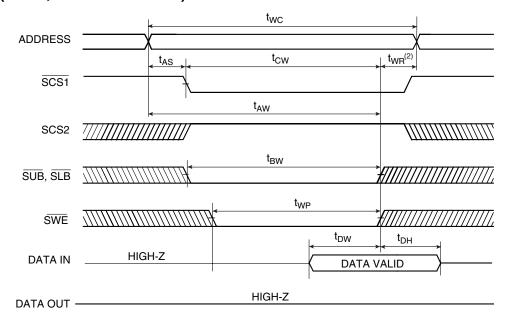




Write Cycle 1 (SWE Controlled)(1),(4),(8)



Write Cycle 2 (SCS1, SCS2 Controlled)(1),(4),(8)



- Notes: 1. A write occurs during the overlap of a low SWE, a low SCS1, a high SCS2 and a low SUB and/or SLB.
 - 2. t_{WB} is measured from the earlier of SCS1, SLB, SUB, or SWE going high or SCS2 going low to the end of write cycle.
 - 3. During this period, I/O pins are in the output state so that the input signals of opposite phase to the output must not be applied.
 - 4. If the SCS1, SLB and SUB low transition and SCS2 high transition occur simultaneously with the SWE low transition or after the SWE transition, outputs remain in a high impedance state.
 - 5. Q (data out) is the same phase with the write data of this write cycle.
 - 6. Q (data out) is the read data of the next address.
 - 7. Transition is measured ± 200 mV from steady state. This parameter is sampled and not 100% tested.
 - 8. SCS1 in high for the standby, low for active SCS2 in low for the standby, high for active. SUB and SLB in high for the standby, low for active.

Data Retention Electric Characteristic

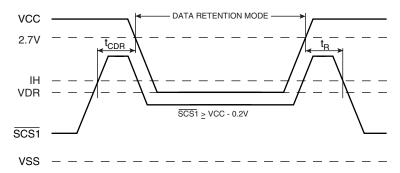
 $T_A = -40^{\circ} \, C$ to $85^{\circ} \, C$

Symbol	Parameter	Test Condition	Min	Тур	Max	Unit
V _{DR}	V _{CC} for Data Retention		1.2		3.3	V
I _{CCDR}	Data Retention Current			1	8	μА
t _{CDR}	Chip Deselect to Data Retention Time	See Data Retention Timing Diagram	0			ns
t _R	Operating Recovery Time		t _{RC}			ns

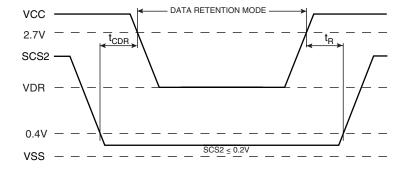
Notes: 1. Typical values are under the condition of $T_A = 25^{\circ}$ C. Typical values are sampled and not 100% tested.

2. t_{RC} is read cycle time.

Data Retention Timing Diagram 1



Data Retention Timing Diagram 2







Ordering Information

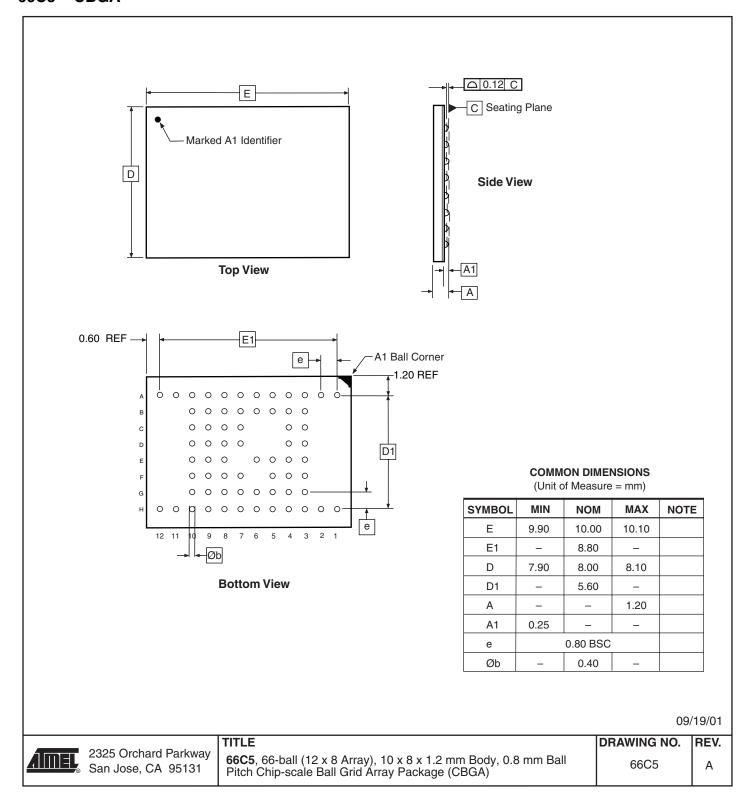
t _{ACC} (ns)	Ordering Code	Flash Boot Block	Flash Plane Architecture	SRAM	Package	Operation Range
70	AT52BR3224A-70CI	Bottom	32M – Single Bank	256K x 16	66C5	Industrial (-40° to 85°C)
70	AT52BR3224AT-70CI	Тор	32M – Single Bank	256K x 16	66C5	Industrial (-40° to 85°C)
70	AT52BR3228A-70CI	Bottom	32M – Single Bank	512K x 16	66C5	Industrial (-40° to 85°C)
70	AT52BR3228AT-70CI	Тор	32M – Single Bank	512K x 16	66C5	Industrial (-40° to 85°C)

	Package Type
66C5	66-ball, Plastic Chip-size Ball Grid Array Package (CBGA)

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Packaging Information

66C5 - CBGA







Atmel Corporation

2325 Orchard Parkway San Jose, CA 95131 Tel: 1(408) 441-0311 Fax: 1(408) 487-2600

Regional Headquarters

Europe

Atmel Sarl Route des Arsenaux 41 Case Postale 80 CH-1705 Fribourg Switzerland

Tel: (41) 26-426-5555 Fax: (41) 26-426-5500

Asia

Room 1219 Chinachem Golden Plaza 77 Mody Road Tsimshatsui East Kowloon Hong Kong

Tel: (852) 2721-9778 Fax: (852) 2722-1369

Japan

9F, Tonetsu Shinkawa Bldg. 1-24-8 Shinkawa Chuo-ku, Tokyo 104-0033 Japan

Tel: (81) 3-3523-3551 Fax: (81) 3-3523-7581

Atmel Operations

Memory

2325 Orchard Parkway San Jose, CA 95131 Tel: 1(408) 441-0311 Fax: 1(408) 436-4314

Microcontrollers

2325 Orchard Parkway San Jose, CA 95131 Tel: 1(408) 441-0311 Fax: 1(408) 436-4314

La Chantrerie BP 70602 44306 Nantes Cedex 3, France Tel: (33) 2-40-18-18-18 Fax: (33) 2-40-18-19-60

ASIC/ASSP/Smart Cards

Zone Industrielle 13106 Rousset Cedex, France Tel: (33) 4-42-53-60-00

Fax: (33) 4-42-53-60-01

1150 East Cheyenne Mtn. Blvd. Colorado Springs, CO 80906

Tel: 1(719) 576-3300 Fax: 1(719) 540-1759

Scottish Enterprise Technology Park Maxwell Building East Kilbride G75 0QR, Scotland

Tel: (44) 1355-803-000 Fax: (44) 1355-242-743

RF/Automotive

Theresienstrasse 2 Postfach 3535 74025 Heilbronn, Germany Tel: (49) 71-31-67-0 Fax: (49) 71-31-67-2340

1150 East Cheyenne Mtn. Blvd. Colorado Springs, CO 80906

Tel: 1(719) 576-3300 Fax: 1(719) 540-1759

Biometrics/Imaging/Hi-Rel MPU/ High Speed Converters/RF Datacom Avenue de Rochepleine

BP 123

38521 Saint-Egreve Cedex, France

Tel: (33) 4-76-58-30-00 Fax: (33) 4-76-58-34-80

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